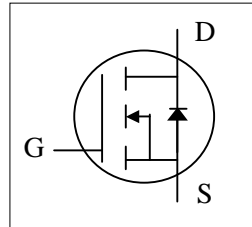




- ▼ Low Gate Charge
- ▼ Simple Drive Requirement
- ▼ Fast Switching Characteristic
- ▼ RoHS Compliant & Halogen-Free

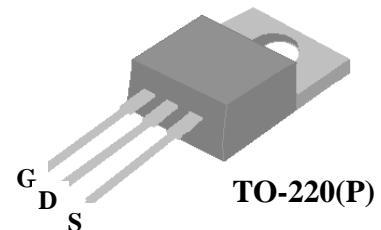
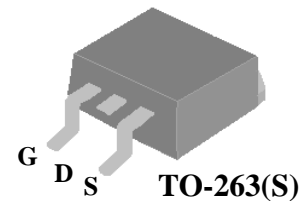


BV_{DSS}	60V
$R_{DS(ON)}$	12m Ω
I_D	72A

Description

AP9974 series are from Advanced Power innovated design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

The TO-263 package is widely preferred for all commercial-industrial surface mount applications using infrared reflow technique and suited for high current application due to the low connection resistance. The through-hole version (AP9974GP) are available for low-profile applications.



Absolute Maximum Ratings @ $T_J=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-Source Voltage	± 20	V
$I_D @ T_C=25^\circ\text{C}$	Drain Current, V_{GS} @ 10V	72	A
$I_D @ T_C=100^\circ\text{C}$	Drain Current, V_{GS} @ 10V	46	A
I_{DM}	Pulsed Drain Current ¹	300	A
$P_D @ T_C=25^\circ\text{C}$	Total Power Dissipation	104	W
	Linear Derating Factor	0.8	W/ $^\circ\text{C}$
E_{AS}	Single Pulse Avalanche Energy ³	45	mJ
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
T_J	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$

Thermal Data

Symbol	Parameter	Value	Units
Rthj-c	Maximum Thermal Resistance, Junction-case	1.2	$^\circ\text{C}/\text{W}$
Rthj-a	Maximum Thermal Resistance, Junction-ambient (PCB mount) ⁴	40	$^\circ\text{C}/\text{W}$
Rthj-a	Maximum Thermal Resistance, Junction-ambient	62	$^\circ\text{C}/\text{W}$



Electrical Characteristics @ T_j=25°C (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250uA	60	-	-	V
ΔBV _{DSS} /ΔT _j	Breakdown Voltage Temperature Coefficient	Reference to 25°C, I _D =1mA	-	0.07	-	V/°C
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =10V, I _D =45A	-	-	12	mΩ
		V _{GS} =4.5V, I _D =30A	-	-	15	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250uA	1	-	3	V
g _{fs}	Forward Transconductance	V _{DS} =10V, I _D =30A	-	50	-	S
I _{DSS}	Drain-Source Leakage Current	V _{DS} =60V, V _{GS} =0V	-	-	10	uA
I _{GSS}	Gate-Source Leakage	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
Q _g	Total Gate Charge	I _D =30A	-	43	69	nC
Q _{gs}	Gate-Source Charge	V _{DS} =48V	-	8	-	nC
Q _{gd}	Gate-Drain ("Miller") Charge	V _{GS} =4.5V	-	31	-	nC
t _{d(on)}	Turn-on Delay Time	V _{DS} =30V	-	14	-	ns
t _r	Rise Time	I _D =30A	-	48	-	ns
t _{d(off)}	Turn-off Delay Time	R _G =3.3Ω	-	42	-	ns
t _f	Fall Time	V _{GS} =10V	-	67	-	ns
C _{iss}	Input Capacitance	V _{GS} =0V	-	3180	5100	pF
C _{oss}	Output Capacitance	V _{DS} =25V	-	495	-	pF
C _{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	460	-	pF
R _g	Gate Resistance	f=1.0MHz	-	1	1.5	Ω

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V _{SD}	Forward On Voltage ²	I _S =45A, V _{GS} =0V	-	-	1.2	V
t _{rr}	Reverse Recovery Time	I _S =30A, V _{GS} =0V,	-	45	-	ns
Q _{rr}	Reverse Recovery Charge	dI/dt=100A/μs	-	40	-	nC

Notes:

1. Pulse width limited by Max. junction temperature.
2. Pulse test
3. Starting T_j=25°C, L=0.1mH, R_G=25Ω, I_{AS}=30A.
4. Surface mounted on 1 in² copper pad of FR4 board

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

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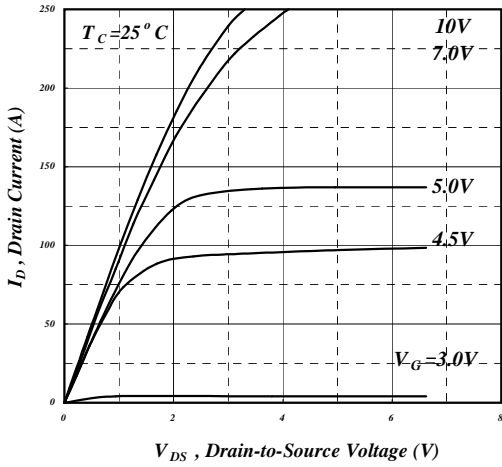


Fig 1. Typical Output Characteristics

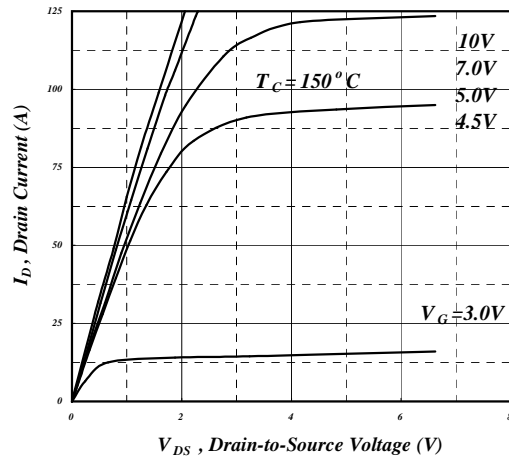


Fig 2. Typical Output Characteristics

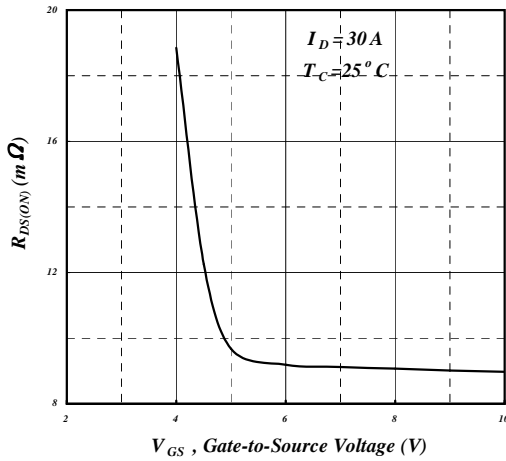


Fig 3. On-Resistance v.s. Gate Voltage

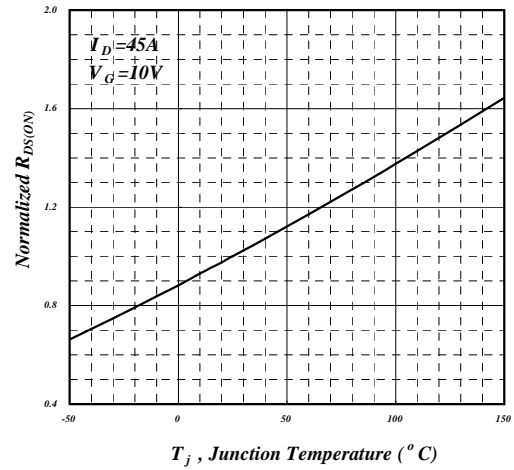


Fig 4. Normalized On-Resistance v.s. Junction Temperature

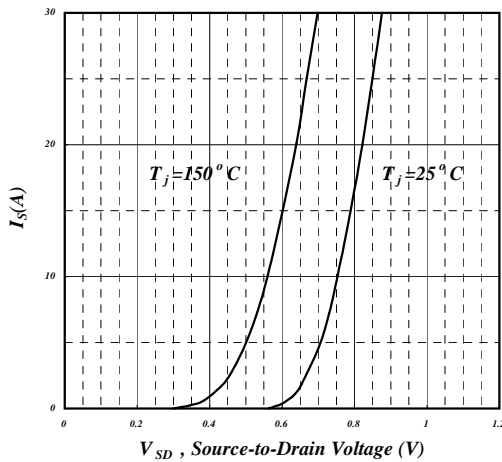


Fig 5. Forward Characteristic of Reverse Diode

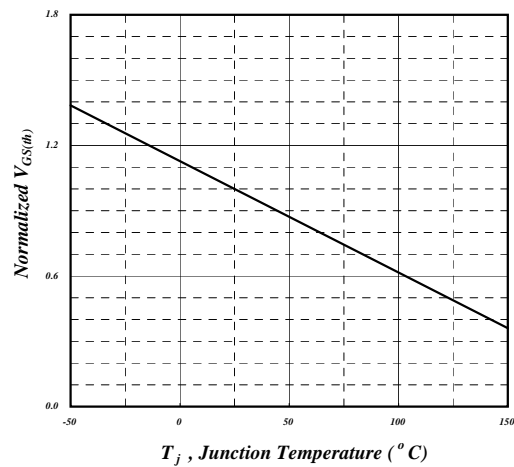


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

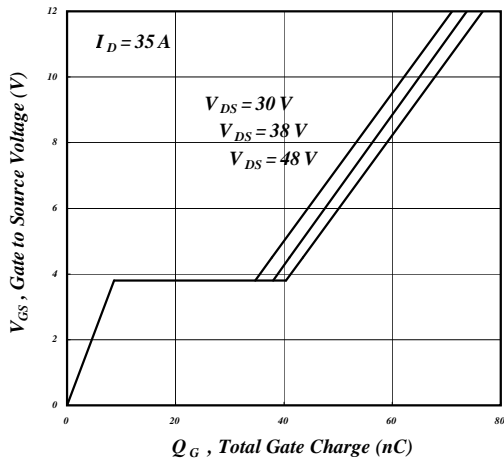


Fig 7. Gate Charge Characteristics

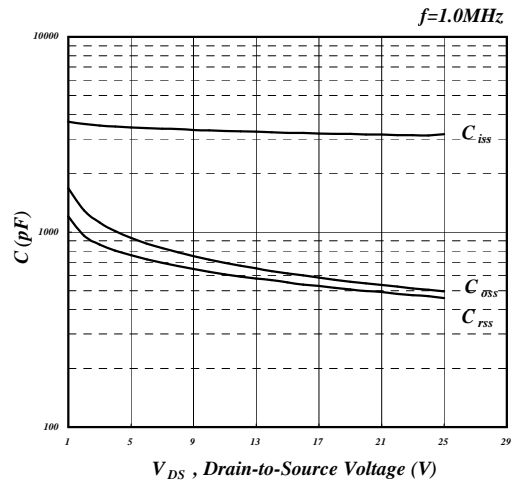


Fig 8. Typical Capacitance Characteristics

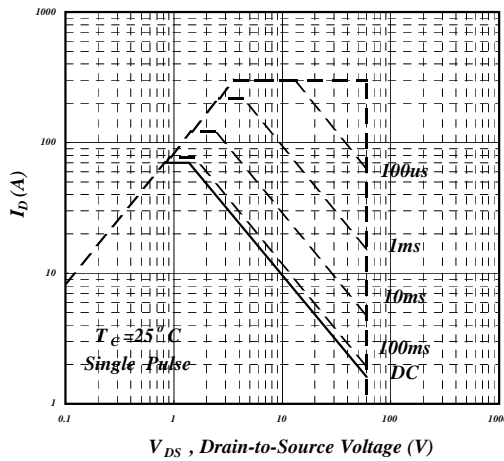


Fig 9. Maximum Safe Operating Area

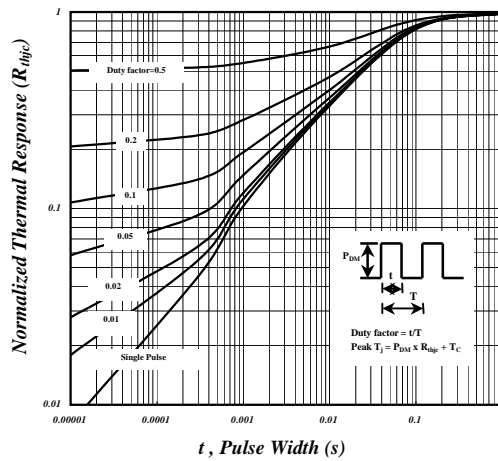


Fig 10. Effective Transient Thermal Impedance

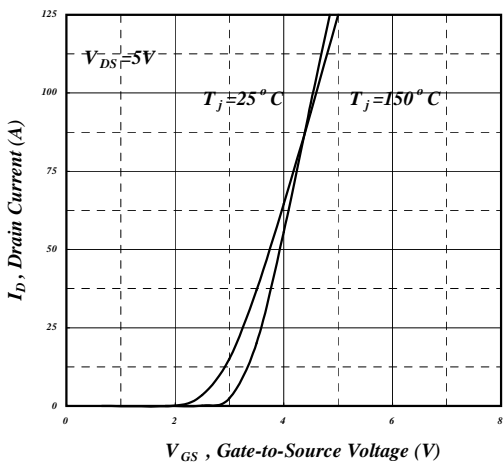


Fig 11. Transfer Characteristics

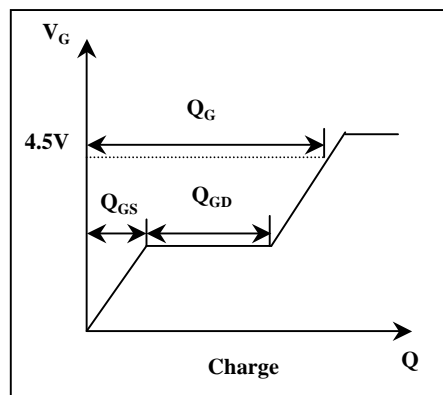
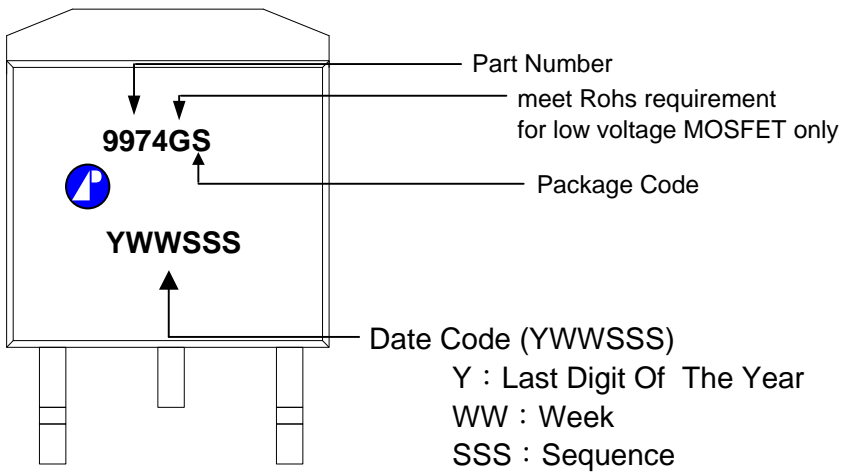


Fig 12. Gate Charge Waveform



MARKING INFORMATION

TO-263



TO-220

